

Search Notes

Application/Control No.

10/038,271

Examiner

Dave T. Nguyen

Applicant(s)/Patent under
Reexamination

FALLAUX ET AL.

Art Unit

1632

SEARCHED

Class	Subclass	Date	Examiner
same as	set forth previously	5/30/2005	DTN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor names searched, related applications checked	5/31/2005	DTN